



### 100V N-CHANNEL ENHANCEMENT MODE MOSFET

### **Product Summary**

V <sub>(BR)DSS</sub>	R <sub>DS(on) max</sub>	I <sub>D</sub> T <sub>A</sub> = +25°C
1001/	220mΩ @ V <sub>GS</sub> = 10V	2.24A
100V	250mΩ @ V <sub>GS</sub> = 4.5V	2.10A

## **Description**

This new generation MOSFET is designed to minimize the on-state resistance (R<sub>DS(on)</sub>) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

## **Applications**

- DC-DC Converters
- Power Management Functions
- Backlighting

### **Features and Benefits**

- Low Input Capacitance
- Low On-Resistance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

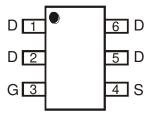
### **Mechanical Data**

- Case: TSOT26
- Case Material: Molded Plastic, "Green" Molding Compound;
   UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Tin Finish Annealed over Copper Leadframe;
   Solderable per MIL-STD-202, Method 208<sup>®</sup>
- Weight: 0.013 grams (Approximate)

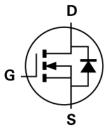




Top View



Top View Pin Configuration



Equivalent Circuit

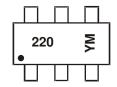
### **Ordering Information** (Note 4)

Part Number	Case	Packaging
DMN10H220LVT-7	TSOT26	3,000/Tape & Reel
DMN10H220LVT-13	TSOT26	10.000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

### **Marking Information**



220 = Product Type Marking Code YM = Date Code Marking Y or \( \bar{Y} = Year (ex: C = 2015) \) M = Month (ex: 9 = September)

Date Code Key

Year	2015		2016	2017		2018	2019		2020	2021		2022
Code	С		D	Е		F	G		Н			J
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



# Maximum Ratings (@T<sub>A</sub> = +25°C unless otherwise specified.)

Characteristic		Symbol	Value	Units	
Drain-Source Voltage			$V_{DSS}$	100	V
Gate-Source Voltage			V <sub>GSS</sub>	±16	V
Continuous Dusin Comment (Note EV)	(Note 6)	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I <sub>D</sub>	2.24 1.79	А
Continuous Drain Current (Note 5) V <sub>GS</sub> = 10V	(Note 5)	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I <sub>D</sub>	1.87 1.50	А
Maximum Continuous Body Diode Forward Current (Note 6)			Is	1.50	Α
Pulsed Drain Current (10µs pulse, duty cycle = 1%)			I <sub>DM</sub>	6.60	Α

## Thermal Characteristics (@TA = +25°C unless otherwise specified.)

Characteristic		Symbol	Value	Units	
Total Power Dissipation (Note 6)	$T_A = +25^{\circ}C$	D	1.67	W	
Total Fower Dissipation (Note 6)	$T_A = +70^{\circ}C$	$P_{D}$	1.07		
Thermal Resistance, Junction to Ambient	(Note 6)	D	75	°C/W	
Thermal nesistance, Junction to Ambient	(Note 5)	$R_{\theta JA}$	108		
Operating and Storage Temperature Range		$T_{J_1}T_{STG}$	-55 to +150	°C	

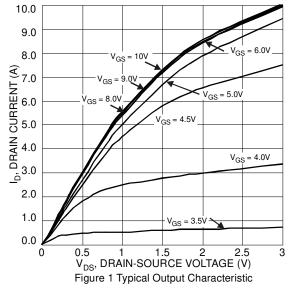
# Electrical Characteristics (@T<sub>A</sub> = +25°C unless otherwise specified.)

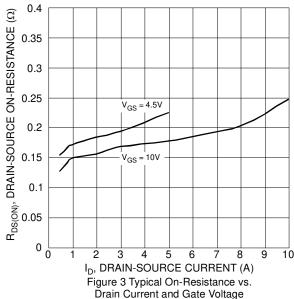
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	100	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	1	μΑ	$V_{DS} = 100V, V_{GS} = 0V$	
Gate-Source Leakage	Igss	_	_	±100	nA	$V_{GS} = \pm 16V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	V <sub>GS(th)</sub>	1	1.8	2.5	٧	$V_{DS} = V_{GS}, I_D = 250 \mu A$	
Static Drain-Source On-Resistance			172	220	mΩ	$V_{GS} = 10V, I_D = 1.6A$	
Static Drain-Source On-Nesistance	R <sub>DS</sub> (ON)	_	211	250	11122	$V_{GS} = 4.5V, I_D = 1.3A$	
Diode Forward Voltage	$V_{SD}$	_	0.77	1.2	V	$V_{GS} = 0V, I_{S} = 1.1A$	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	C <sub>iss</sub>		401	_		V 25V V 0V	
Output Capacitance	Coss	_	22	_	pF	$V_{DS} = 25V, V_{GS} = 0V$ f = 1MHz	
Reverse Transfer Capacitance	C <sub>rss</sub>	_	17	_		1 = 1101112	
Gate Resistance	$R_g$	_	2.1		Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$	
Total Gate Charge (V <sub>GS</sub> = 4.5V)	Qg	_	4.1	_			
Total Gate Charge (V <sub>GS</sub> = 10V)	$Q_g$	_	8.3	_	nC	Vps = 50V. Ip = 1.6A	
Gate-Source Charge	Qgs	_	1.5	_	110	VDS = 50V, ID = 1.6A	
Gate-Drain Charge	$Q_{gd}$	_	2	_			
Turn-On Delay Time	t <sub>D(on)</sub>	_	6.8	_			
Turn-On Rise Time	t <sub>r</sub>	_	8.2	_		$V_{DS} = 50V, V_{GS} = 4.5V,$	
Turn-Off Delay Time	t <sub>D(off)</sub>	_	7.9	_	ns	$R_G = 6.8\Omega$ , $I_D = 1A$	
Turn-Off Fall Time	t <sub>f</sub>	_	3.6	_			
Reverse Recovery Time	t <sub>rr</sub>	_	17	_	ns	1 1 1 A di/dt 1000/up	
Reverse Recovery Charge	Q <sub>rr</sub>	_	9.8	_	nC	I <sub>F</sub> = 1.1A, di/dt =100A/μs	

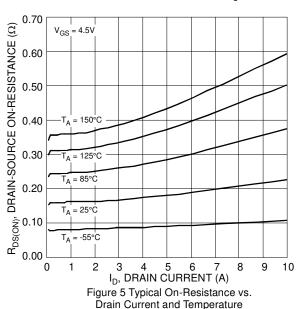
Notes:

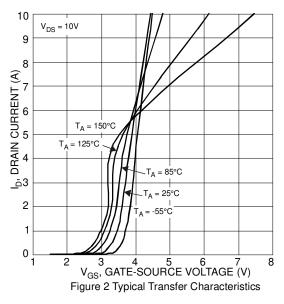
- 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.6. Device mounted on FR-4 substrate PC board, 2oz copper, with thermal vias to bottom layer 1-inch square copper plate.
- 7 .Short duration pulse test used to minimize self-heating effect.
- 8. Guaranteed by design. Not subject to production testing.

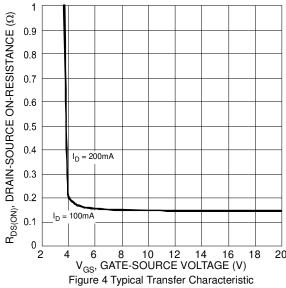












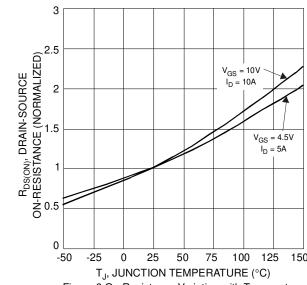
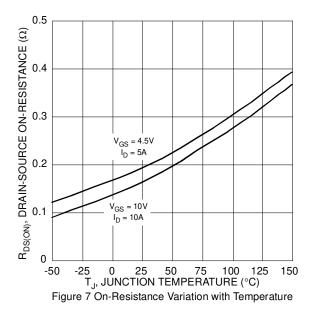


Figure 6 On-Resistance Variation with Temperature





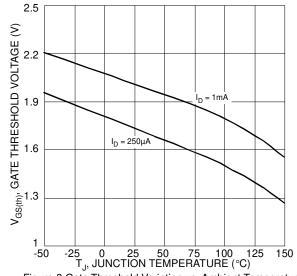
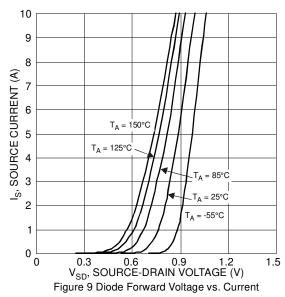
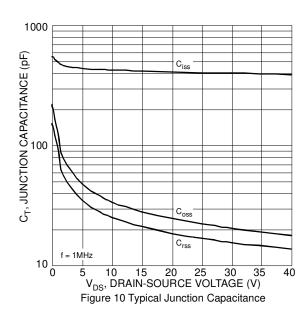
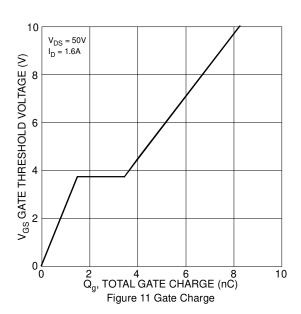
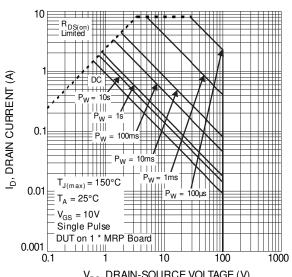


Figure 8 Gate Threshold Variation vs. Ambient Temperature



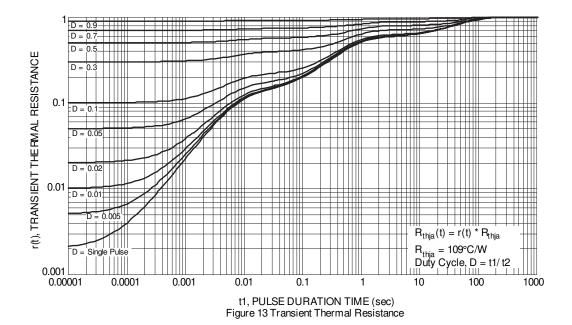






 ${
m V_{DS}},{
m DRAIN\text{-}SOURCE\,VOLTAGE\,(V)}$  Figure 12 SOA, Safe Operation Area

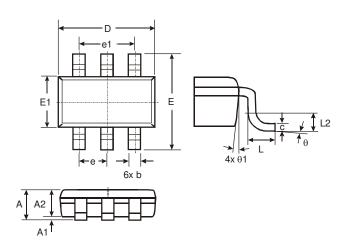






## **Package Outline Dimensions**

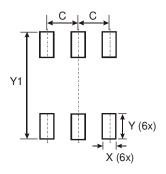
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.



	TSOT26								
Dim	Min	Max	Тур						
Α		1.00							
<b>A</b> 1	0.01	0.10	-						
A2	0.84	0.90	-						
D			2.90						
Е			2.80						
E1			1.60						
b	0.30	0.45	1						
С	0.12	0.20	1						
е			0.95						
e1			1.90						
L	0.30	0.50	_						
L2			0.25						
θ	0°	8°	4°						
θ1	4°	12°	_						
All D	All Dimensions in mm								

# **Suggested Pad Layout**

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
С	0.950
Х	0.700
Υ	1.000
Y1	3.199



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